## Notice of References Cited Application/Control No. 10/520,941 Examiner SHEWANA SKINNER Applicant(s)/Patent Under Reexamination ISHIMARU ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0046307	03-2003	Rivette et al.	707/104.1
*	В	US-7,127,405	10-2006	Frank et al.	705/310
*	C	US-2002/0087442	07-2002	Reader, Scot A.	705/31
*	D	US-2002/0077835	06-2002	Hagelin, Theodore	705/1
*	Е	US-2002/0035499	03-2002	Germeraad et al.	705/9
*	F	US-2002/0040338	04-2002	Sick et al.	705/37
*	G	US-2004/0122841	06-2004	Goodman et al.	707/102
*	Η	US-2002/0046038	04-2002	Prokoski, Francine J.	705/1
*	I	US-2008/0091620	04-2008	Vollenweider et al.	705/36.R
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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